

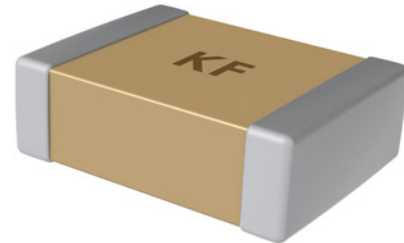
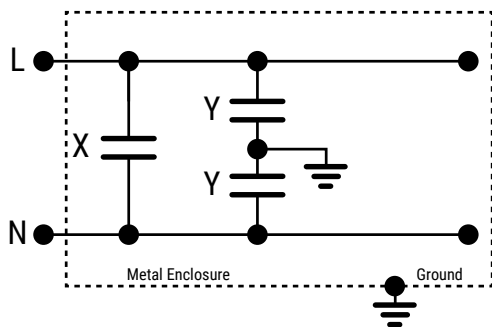
Safety Certified, CAS, Surface Mount X1/Y2 250 VAC, X2 250 VAC (Industrial Grade)

Overview

KEMET's CAS surface mount safety certified capacitors are specifically designed for interference-suppression AC line filtering applications. When comparing to radial leaded disc capacitors, the CAS surface mount form factor provides engineers the ability to miniaturize their designs with a higher density solution. Having internationally recognized safety certifications, these capacitors are well-suited for applications that require keeping potentially disruptive or damaging line transients and EMI out of susceptible equipment. They are also an ideal solution when needing to suppress line disturbances at the source.

Safety Certified Capacitors are classified as either X and/or Y capacitors. Class X capacitors are primarily used in line-to-line (across-the-line) applications. Should the capacitor fail in this application, there is no danger of electric shock to humans but could result in a risk of fire. The Class Y capacitor is primarily used in line-to-ground (line by-pass) applications. In this application, failure of the capacitor could lead to danger of electric shock.

With a working voltage of 250 VAC in line-to-line (Class X) and 250 VAC in line-to-ground (Class Y) applications, these safety capacitors meet the impulse test criteria outlined in IEC Standard 60384. Meeting subclass X1 and Y2 requirements, these devices are certified to withstand impulses up to 5 kV (X1/Y2) and 2.5 kV (X2) respectively.



Benefits

- Safety Certified to IEC 60384-14
- Class X1/Y2, X2
- 250 VAC rating
- 2.5 kV and 5 kV Impulse Voltages
- Reliable operation up to 125°C
- Available in C0G and X7R Dielectrics
- Case sizes 1808, 1812, 2211, and 2220
- Capacitance offerings ranging from 3.0 pF to 22 nF
- Available capacitance tolerances from ± 0.5 pF to $\pm 20\%$
- RoHS compliant

Applications

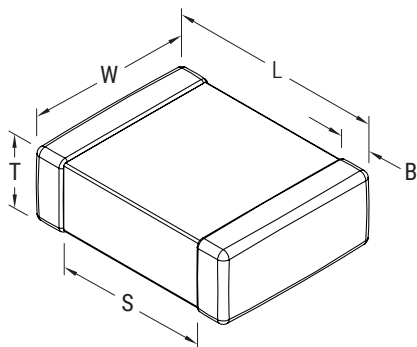
Typical applications include:

- Line-to-line (Class X) filtering
- Line-to-ground (Class Y) filtering
- Antenna coupling
- Primary and secondary coupling (switching power supplies)
- Line disturbances suppression (motors and motor controls, relays, switching power supplies, and inverters)

Ordering Information

CAS	17	C	471	K	A	G	F	C	
Type	Case Size (L"x W")	Specification/ Series	Capacitance Code (pF)	Capacitance Tolerance	AC Rated Voltage	Dielectric	Subclass Designation	Termination Finish	Packaging (Suffix/C-Spec)
CAS = AC Safety Rated	17 = 1808 18 = 1812 21 = 2220 26 = 2211	C	Two significant digits + number of zeros. Use 9 for 1.0 – 9.9 pF e.g., 2.2 pF = 229	D = ± 0.5 pF F = $\pm 1\%$ G = $\pm 2\%$ J = $\pm 5\%$ K = $\pm 10\%$ M = $\pm 20\%$	A = 250 VAC	G = C0G R = X7R	F = X1/Y2 G = X2	C = 100% Matte Sn	Blank = 7" Reel

Dimensions – Millimeters (Inches)



EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
1808	4520	4.50 (0.177) +0.50 (0.020)/-0.30 (0.012)	2.00 (0.080) ± 0.25 (0.010)	See Table 2 for Thickness	0.50 (0.020) ± 0.25 (0.010)	> 3.50 (0.138)	Solder Reflow Only
1812	4532	4.50 (0.177) +0.50 (0.020)/-0.30 (0.012)	3.20 (0.126) ± 0.40 (0.016)		0.50 (0.020) ± 0.25 (0.010)	> 3.50 (0.138)	
2211	5728	5.70 (0.224) ± 0.40 (0.016)	2.80 (0.110) ± 0.30 (0.012)		0.60 (0.024) ± 0.30 (0.012)	> 4.00 (0.157)	
2220	5750	5.70 (0.224) ± 0.40 (0.016)	5.00 (0.197) ± 0.40 (0.016)		0.60 (0.024) ± 0.30 (0.012)	> 4.00 (0.157)	

Qualification

Safety Standard	Specification	Subclass	Working Voltage	Certificate No.
TUV	IEC 60384-14	X1/Y2	250 VAC	R 50441101
		X2		R 50441118
UL CAN/CSA	UL 60384-14 and E60384-14	X1/Y2	250 VAC	E356389
		X2		

These devices are TUV/ENEC recognized for antenna coupling and AC line-to-line (Class X) and line-to-ground (Class Y) applications per IEC60384-14.

Environmental Compliance

These devices are RoHS compliant. They meet all requirements set forth by EU RoHS directives.



Table 1A – Product Ordering Codes & Ratings – X1/Y2 C0G

Capacitance	Capacitance Code	Case Size						1808	1812	2211
		Class						X1/Y2		
		Peak Impulse Voltage						5,000 V		
		Capacitance Tolerance						Product Availability and Chip Thickness Codes See Table 2 for Chip Thickness Dimensions		
3.0 pF	309	D						AF		
3.3 pF	339	D						AF		
3.9 pF	399	D						AF		
4.0 pF	409	D						AF		CK
4.7 pF	479	D						AF		CK
5.0 pF	509	D						AF		CK
5.6 pF	569	D						AF		CK
6.0 pF	609	D						AF		CK
6.8 pF	689	D						AF		CK
7.0 pF	709	D						AF		CK
8.0 pF	809	D						AF		CK
8.2 pF	829	D						AF		CK
10 pF	100		F	G	J	K	M	AF	BD	CK
12 pF	120		F	G	J	K	M	AF	BD	CK
15 pF	150		F	G	J	K	M	AF	BD	CK
18 pF	180		F	G	J	K	M	AF	BD	CK
22 pF	220		F	G	J	K	M	AF	BD	CK
27 pF	270		F	G	J	K	M	AF	BD	CK
33 pF	220		F	G	J	K	M	AF	BD	CK
39 pF	390		F	G	J	K	M	AG	BD	CK
47 pF	470		F	G	J	K	M	AG	BD	CK
56 pF	560		F	G	J	K	M	AG	BD	CK
68 pF	680		F	G	J	K	M	AG	BD	CK
82 pF	820		F	G	J	K	M	AG	BD	CK
100 pF	101		F	G	J	K	M	AK	BD	CK
120 pF	121		F	G	J	K	M	AK	BD	CM
150 pF	151		F	G	J	K	M	AK	BD	CM
160 pF	161		F	G	J	K	M	AK	BD	CM
180 pF	181		F	G	J	K	M	AK	BD	CM
220 pF	221		F	G	J	K	M	AK	BK	CM
270 pF	271		F	G	J	K	M	AK	BK	CM
330 pF	331		F	G	J	K	M		BK	CM
390 pF	391		F	G	J	K	M		BK	CM
470 pF	471		F	G	J	K	M		BK	CM
560 pF	561		F	G	J	K	M		BK	CM
680 pF	681		F	G	J	K	M			CM
720 pF	721		F	G	J	K	M			
820 pF	821		F	G	J	K	M			
1,000 pF	102		F	G	J	K	M			

Table 1B – Product Ordering Codes & Ratings – X1/Y2 X7R

Capacitance	Capacitance Code	Case Size			1808	1812	2211	2220
		Class			X1/Y2			
		Peak Impulse Voltage			5,000V			
		Capacitance Tolerance			Product Availability and Chip Thickness Codes See Table 2 for Chip Thickness Dimensions			
100 pF	101	J	K	M	AG			
120 pF	121	J	K	M	AG			
150 pF	151	J	K	M	AG			
180 pF	181	J	K	M	AG	BG	CG	DK
220 pF	221	J	K	M	AG	BG	CG	DK
270 pF	271	J	K	M	AK	BG	CG	DK
330 pF	331	J	K	M	AK	BG	CG	DK
390 pF	391	J	K	M	AK	BG	CG	DK
470 pF	471	J	K	M	AK	BG	CK	DK
560 pF	561	J	K	M	AK	BG	CK	DK
680 pF	681	J	K	M	AK	BK	CK	DK
820 pF	821	J	K	M	AK	BK	CK	DK
1,000 pF	102	J	K	M	AK	BM	CM	DK
1,200 pF	122	J	K	M			CM	DM
1,500 pF	152	J	K	M			CM	DM
1,800 pF	182	J	K	M			CM	DM
2,200 pF	222	J	K	M			CM	DM
2,700 pF	272	J	K	M				DM
3,300 pF	332	J	K	M				DM
3,900 pF	392	J	K	M				DM
4,700 pF	472	J	K	M				DM

Table 1C – Product Ordering Codes & Ratings – X2 C0G

Capacitance	Capacitance Code	Case Size						1808	1812
		Class						X2	
		Peak Impulse Voltage						2,500V	
		Capacitance Tolerance						Product Availability and Chip Thickness Codes See Table 2 for Chip Thickness Dimensions	
3.0 pF	309	D						AF	
4.0 pF	409	D						AF	
5.0 pF	509	D						AF	
6.0 pF	609	D						AF	
7.0 pF	709	D						AF	
8.0 pF	809	D						AF	
9.0 pF	909	D						AF	
10 pF	100		F	G	J	K	M	AF	BD
12 pF	120		F	G	J	K	M	AF	BD
15 pF	150		F	G	J	K	M	AF	BD
22 pF	220		F	G	J	K	M	AF	BD
27 pF	270		F	G	J	K	M	AF	BD
33 pF	330		F	G	J	K	M	AF	BD
39 pF	390		F	G	J	K	M	AG	BD
47 pF	470		F	G	J	K	M	AG	BD
56 pF	560		F	G	J	K	M	AG	BD
68 pF	680		F	G	J	K	M	AG	BD
82 pF	820		F	G	J	K	M	AG	BD
100 pF	101		F	G	J	K	M	AK	BD
120 pF	121		F	G	J	K	M	AK	BD
150 pF	151		F	G	J	K	M	AK	BD
180 pF	181		F	G	J	K	M	AK	BD
220 pF	221		F	G	J	K	M	AK	BD
270 pF	271		F	G	J	K	M	AK	BF
330 pF	331		F	G	J	K	M	AK	BF
390 pF	391		F	G	J	K	M	AK	BF
470 pF	471		F	G	J	K	M	AK	BG
560 pF	561		F	G	J	K	M	AK	BK
680 pF	681		F	G	J	K	M	AK	BK
820 pF	821		F	G	J	K	M	AK	BM
1,000 pF	102		F	G	J	K	M	AK	BM

Table 1D – Product Ordering Codes & Ratings – X2 X7R

Capacitance	Capacitance Code	Case Size			1808	1812	2220
		Class			X2		
		Peak Impulse Voltage			2,500V		
		Capacitance Tolerance			Product Availability and Chip Thickness Codes See Table 2 for Chip Thickness Dimensions		
150 pF	151	J	K	M	AG		
180 pF	181	J	K	M	AG		
220 pF	221	J	K	M	AG		
270 pF	271	J	K	M	AG	BG	
300 pF	301	J	K	M	AG	BG	
330 pF	331	J	K	M	AG	BG	
390 pF	391	J	K	M	AG	BG	
470 pF	471	J	K	M	AG	BG	
560 pF	561	J	K	M	AG	BG	
680 pF	681	J	K	M	AG	BG	
720 pF	721	J	K	M	AG	BG	
820 pF	821	J	K	M	AG	BG	
1,000 pF	102	J	K	M	AK	BG	
1,200 pF	122	J	K	M	AK	BG	
1,500 pF	152	J	K	M	AK	BK	
1,800 pF	182	J	K	M	AK	BK	
2,200 pF	222	J	K	M	AK	BM	
2,700 pF	272	J	K	M		BM	
3,300 pF	332	J	K	M		BM	
3,900 pF	392	J	K	M		BM	
4,700 pF	472	J	K	M		BM	
5,600 pF	562	J	K	M		BM	
0.010 uF	103	J	K	M			DM
0.012 uF	123	J	K	M			DM
0.015 uF	153	J	K	M			DM
0.018 uF	183	J	K	M			DM
0.022 uF	223	J	K	M			DU

Table 2 – Chip Thickness/Tape & Reel Packaging Quantities

Case Size	Thickness Code	Thickness Range (mm)	Plastic Quantity
1808	AF	1.40±0.15	2,000
	AG	1.60±0.20	2,000
	AK	2.00±0.20	1,000
1812	BD	1.25±0.10	1,000
	BF	1.40±0.15	1,000
	BG	1.60±0.20	1,000
	BK	2.00±0.20	1,000
	BM	2.50±0.30	500
2211	CG	1.60±0.20	1,000
	CK	2.00±0.20	1,000
	CM	2.50±0.30	500
	CU	2.80±0.30	500
2220	DK	2.00±0.20	1,000
	DM	2.50±0.30	500
	DU	2.80±0.30	500

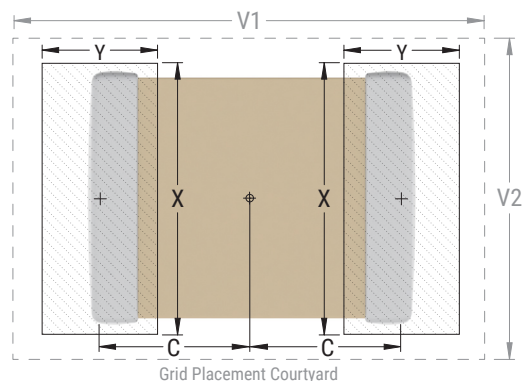
Table 3 – Chip Capacitor Land Pattern Design Recommendations per IPC-7351

EIA Size Code	Metric Size Code	Density Level A: Maximum (Most) Land Protrusion (mm)					Density Level B: Median (Nominal) Land Protrusion (mm)					Density Level C: Minimum (Least) Land Protrusion (mm)				
		C	Y	X	V1	V2	C	Y	X	V1	V2	C	Y	X	V1	V2
1808	4520	2.30	1.75	2.30	7.40	3.30	2.20	1.55	2.20	6.50	2.70	2.10	1.35	2.10	5.80	2.40
1812	4532	2.15	1.60	3.60	6.90	4.60	2.05	1.40	3.50	6.00	4.00	1.95	1.20	3.40	5.30	3.70
2211	5728	2.81	1.70	3.21	7.30	3.40	2.76	1.60	3.11	7.10	3.50	2.71	1.50	3.01	6.90	3.30
2220	5650	2.75	1.70	5.50	8.20	6.50	2.65	1.50	5.40	7.30	5.90	2.55	1.30	5.30	6.60	5.60

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes.

Density Level C: For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC-7351).

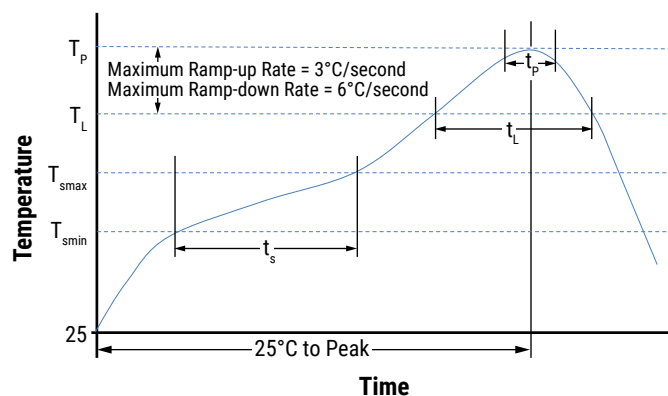


Soldering Process

Recommended Reflow Soldering Profile

KEMET's family of surface mount multilayer ceramic capacitors (SMD MLCCs) are compatible with wave (single or dual), convection, IR or vapor phase reflow techniques. Preheating of these components is recommended to avoid extreme thermal stress. KEMET's recommended profile conditions for convection and IR reflow reflect the profile conditions of the IPC/J-STD-020 standard for moisture sensitivity testing. These devices can safely withstand a maximum of three reflow passes at these conditions.

Profile Feature	Termination Finish
	100% Matte Sn
Preheat/Soak	
Temperature Minimum (T_{smin})	150°C
Temperature Maximum (T_{smax})	200°C
Time (t_s) from T_{smin} to T_{smax}	60 – 120 seconds
Ramp-Up Rate (T_L to T_p)	3°C/second maximum
Liquidous Temperature (T_L)	217°C
Time Above Liquidous (t_L)	60 – 150 seconds
Peak Temperature (T_p)	260°C
Time Within 5°C of Maximum Peak Temperature (t_p)	30 seconds maximum
Ramp-Down Rate (T_p to T_L)	6°C/second maximum
Time 25°C to Peak Temperature	8 minutes maximum

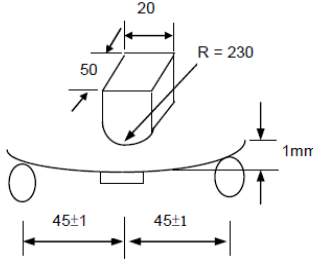
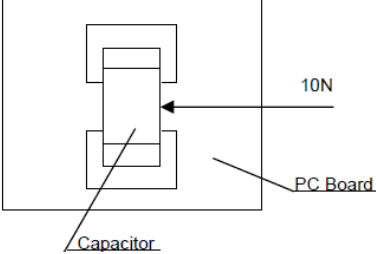


Note: All temperatures refer to the center of the package, measured on the capacitor body surface that is facing up during assembly reflow.

Table 4 – Performance & Reliability: Test Methods and Conditions

Item	Standard	Specification	Requirements																							
Visual examination and Dimensions	IEC 60384-1 4.1		No remarkable defect. Dimensions to conform to individual specification sheet.																							
Capacitance	IEC 60384-1 4.2.2	Class I: C0G Capacitance ≤ 1,000 pF, 1.0 ±0.2 V _{rms} , 1 MHz ±10% Capacitance > 1,000 pF, 1.0 ±0.2 V _{rms} , 1 KHz ±10% Class II: (X7R) 1.0 ±0.2 V _{rms} , 1 kHz ±10%	Capacitance is within specified tolerance																							
Dissipation Factor (DF) or Q	IEC 60384-1 4.2.3		<table><tr><th>Dielectric</th><th>Q/DF</th><th>Requirement</th></tr><tr><td rowspan="2">C0G</td><td>Q ≥ 1,000</td><td>Cap ≥ 30 pF</td></tr><tr><td>Q ≥ 400 +20C¹</td><td>Cap < 30 pF</td></tr><tr><td>X7R</td><td>D.F. < 2.5%</td><td></td></tr></table>	Dielectric	Q/DF	Requirement	C0G	Q ≥ 1,000	Cap ≥ 30 pF	Q ≥ 400 +20C ¹	Cap < 30 pF	X7R	D.F. < 2.5%													
			Dielectric	Q/DF	Requirement																					
		C0G	Q ≥ 1,000	Cap ≥ 30 pF																						
Q ≥ 400 +20C ¹	Cap < 30 pF																									
X7R	D.F. < 2.5%																									
1. Example for 22 pF: Q ≥ 400 + (20 * 22) = 840																										
Temperature Coefficient	IEC 60384-21/22 4.6	<table><tr><th>Dielectric</th><th>Temperature Range</th></tr><tr><td>C0G</td><td rowspan="2">-55 to 125°C</td></tr><tr><td>X7R</td></tr></table>	Dielectric	Temperature Range	C0G	-55 to 125°C	X7R	<table><tr><th>Dielectric</th><th>Capacitance Change</th></tr><tr><td>C0G</td><td>±30 ppm/°C</td></tr><tr><td>X7R</td><td>±15%</td></tr></table>	Dielectric	Capacitance Change	C0G	±30 ppm/°C	X7R	±15%												
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Dielectric Strength	IEC 60384-14 4.2.1	X Capacitor: 1,075 VDC (4.3 U _R) Y Capacitor: 1,500 VAC Duration = 60 Seconds Charge current shall not exceed 50 mA Voltage shall be raised from zero to test voltage at a rate not exceeding 150 V _{rms} /second	No evidence of flashover																							
Insulation Resistance	IEC 60384-21/22 4.5.3	500 V for 60 seconds <50 mA charging current	<table><tr><th>Dielectric</th><th>Insulation Resistance</th></tr><tr><td>C0G</td><td>1,000 megohm microfarads or 100 GΩ Whichever is smaller</td></tr><tr><td>X7R</td><td>500 megohm microfarads or 10 GΩ Whichever is smaller</td></tr></table>	Dielectric	Insulation Resistance	C0G	1,000 megohm microfarads or 100 GΩ Whichever is smaller	X7R	500 megohm microfarads or 10 GΩ Whichever is smaller																	
Dielectric	Insulation Resistance																									
C0G	1,000 megohm microfarads or 100 GΩ Whichever is smaller																									
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Solderability	IEC 60384-21/22 4.10	Solder temperature: 245±5°C Dipping time: 2±0.2 seconds	75% minimum coverage of all metalized area																							
Resistance to Solder Heat	IEC 60384-14 4.4 IEC 60384-21/22 4.9	Solder temperature: 260 ±5°C Dipping time: 10 ±1 second Preheat 120°C – 150°C for 1 minute before immersing the capacitor in a eutectic solder. For X7R capacitors, measurements can be made after keeping at room temperature for 24 ±2 hours	No visible damage. <table><tr><th>Dielectric</th><th>IR</th><th>Capacitance Change</th></tr><tr><td>C0G</td><td rowspan="2">≥ 1 GΩ</td><td>Within ±2.5% or ±0.25 pF, whichever is larger.</td></tr><tr><td>X7R</td><td>±7.5%</td></tr></table>	Dielectric	IR	Capacitance Change	C0G	≥ 1 GΩ	Within ±2.5% or ±0.25 pF, whichever is larger.	X7R	±7.5%															
Dielectric	IR	Capacitance Change																								
C0G	≥ 1 GΩ	Within ±2.5% or ±0.25 pF, whichever is larger.																								
X7R		±7.5%																								
Temperature Cycling	IEC 60384-21/22 4.11	Five cycles <table><tr><th>Step</th><th>Temp. (°C)</th><th>Time (min.)</th></tr><tr><td>1</td><td>-55°C</td><td>30 ±3</td></tr><tr><td>2</td><td>25°C</td><td>3</td></tr><tr><td>3</td><td>125°C</td><td>30 ±3</td></tr><tr><td>4</td><td>25°C</td><td>3</td></tr></table> Measurements to be made after keeping at room temperature for 24 ±2 hours	Step	Temp. (°C)	Time (min.)	1	-55°C	30 ±3	2	25°C	3	3	125°C	30 ±3	4	25°C	3	<table><tr><th>Dielectric</th><th>IR</th><th>Capacitance Change</th></tr><tr><td>C0G</td><td rowspan="2">Initial Limit</td><td>Within ±2.5% or ±0.25 pF, whichever is larger.</td></tr><tr><td>X7R</td><td>±7.5%</td></tr></table>	Dielectric	IR	Capacitance Change	C0G	Initial Limit	Within ±2.5% or ±0.25 pF, whichever is larger.	X7R	±7.5%
Step	Temp. (°C)	Time (min.)																								
1	-55°C	30 ±3																								
2	25°C	3																								
3	125°C	30 ±3																								
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Dielectric	IR	Capacitance Change																								
C0G	Initial Limit	Within ±2.5% or ±0.25 pF, whichever is larger.																								
X7R		±7.5%																								
Humidity (Damp Heat) Steady State	IEC 60384-14 4.12	Test temperature: 40±2°C Humidity: 90 – 95% RH Test time: 500 +24/-0 hours Applied Voltage: 250 VAC Measurement to be made after keeping at room temperature for 24±2 hours	<table><tr><th>Dielectric</th><th>IR</th><th>Capacitance Change</th></tr><tr><td>C0G</td><td>25 megohm microfarads or 1 GΩ</td><td>Within ±3.0% or ±2 pF, whichever is larger.</td></tr><tr><td>X7R</td><td>Whichever is smaller</td><td>±15%</td></tr></table>	Dielectric	IR	Capacitance Change	C0G	25 megohm microfarads or 1 GΩ	Within ±3.0% or ±2 pF, whichever is larger.	X7R	Whichever is smaller	±15%														
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C0G	25 megohm microfarads or 1 GΩ	Within ±3.0% or ±2 pF, whichever is larger.																								
X7R	Whichever is smaller	±15%																								

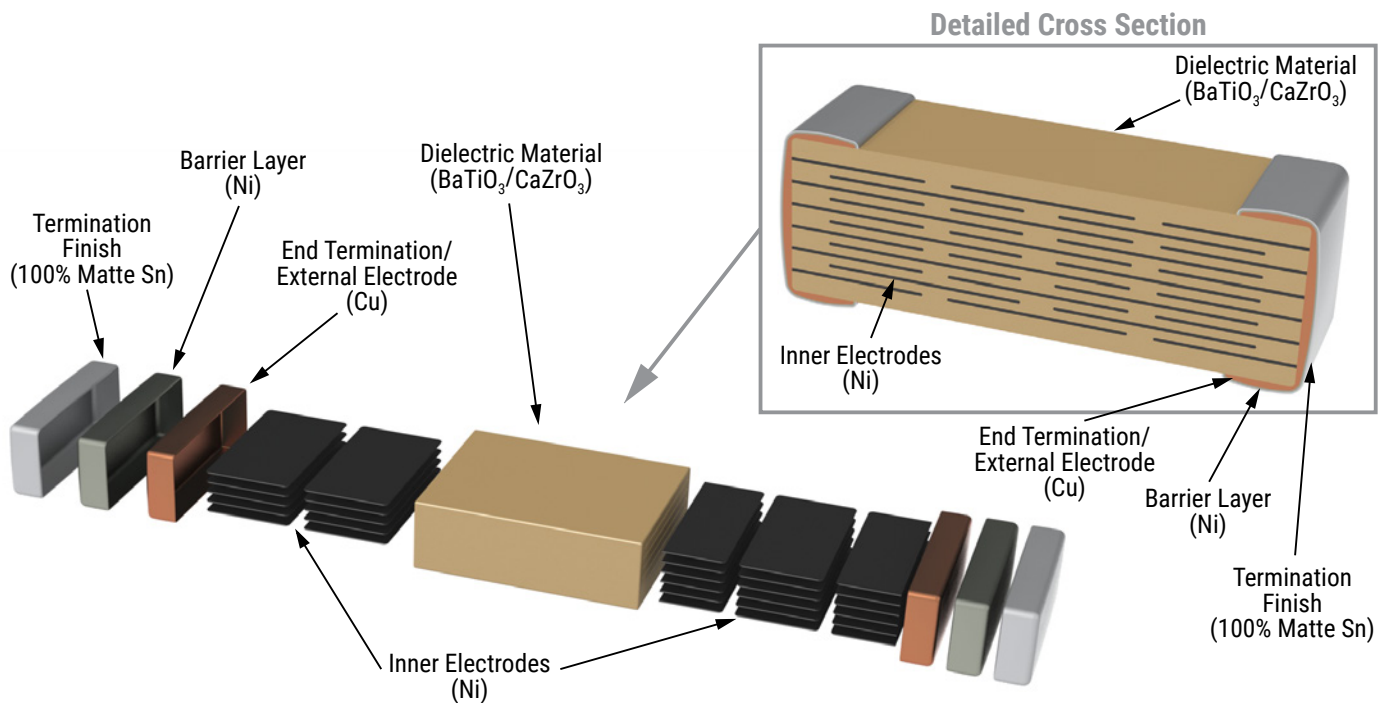
Table 4 – Performance & Reliability: Test Methods and Conditions cont.

Item	Standard	Specification	Requirements											
Passive Flammability	IEC 60384-14 4.17 IEC 60384-1 4.38	Volume sample: 21.56 mm ³ Flame exposure time: 5 seconds maximum Category of flammability: C	No evidence of burning											
Active Flammability	IEC 60384-21/22 4.18	The capacitors applied V _R (250 VAC). Then each sample shall be subjected to 20 discharges from a tank capacitor, charge to a voltage that, when discharged, U _i 2,500 V for X2, U _i 5,000 V for X1/Y2 across the capacitor under test. The interval between successive discharges shall be 5 seconds.	The cheese cloth shall not burn with the flame.											
Endurance	IEC 60384-14 4.14	Impulse Voltage: Each capacitor shall be subjected to a V _p = 5.0 KV (X1/Y2 Class Impulse 5 KV) impulse for three times before applied to endurance test. Test Temp: 125 ±3°C Test time: 1, 000 +48/-0 hours Applied Voltage: X capacitor: 1.25 V _R (312.5 VAC) Y capacitor: 1.70 V _R (425 VAC) Once every hour the voltage shall be increased to 1, 000 V _{rms} for 0.1 second Measurement to be made after keeping at room temperature for 24 ±2 hours	Appearance: No mechanical damage. <table><tr><th>Dielectric</th><th>IR</th><th>Cap. Change</th><th>Q/DF</th></tr><tr><td>C0G</td><td rowspan="2">≥1 GΩ</td><td>Within ±5.0% or ±0.5 pF, whichever is larger.</td><td>≤ 2.5%</td></tr><tr><td>X7R</td><td>±20%</td><td>≤ 5%</td></tr></table>	Dielectric	IR	Cap. Change	Q/DF	C0G	≥1 GΩ	Within ±5.0% or ±0.5 pF, whichever is larger.	≤ 2.5%	X7R	±20%	≤ 5%
Dielectric	IR	Cap. Change	Q/DF											
C0G	≥1 GΩ	Within ±5.0% or ±0.5 pF, whichever is larger.	≤ 2.5%											
X7R		±20%	≤ 5%											
Resistance to Flexure of Substrate	IEC 60384-21/22 4.8	Capacitors mounted on substrate. The board shall be bent 1 mm with rate of 1 mm/second 	<table><tr><th>Dielectric</th><th>Capacitance Change</th></tr><tr><td>C0G</td><td>Within ±3.0% or ±2 pF, whichever is larger.</td></tr><tr><td>X7R</td><td>±12.5%</td></tr></table>	Dielectric	Capacitance Change	C0G	Within ±3.0% or ±2 pF, whichever is larger.	X7R	±12.5%					
Dielectric	Capacitance Change													
C0G	Within ±3.0% or ±2 pF, whichever is larger.													
X7R	±12.5%													
Robustness of terminations (Adhesive Strength of Termination)	IEC 60384-21/22 4.15 IEC 60384-1 4.13	Capacitors mounted on a substrate. A force of 10 N applied perpendicular to the place of substrate and parallel the line joining the center of terminations for 10 ±1 second. 	No remarkable damage or removal of the terminations											
Vibration	IEC 60384-14 4.17	• Vibration frequency : 10~55 Hz/minute • Total amplitude : 1.5 mm • Repeat the conditions for 2 hours each in 3 perpendicular directions	• No remarkable damage • Capacitance change and Q/D.F.: To meet initial specification											
Impulse Voltage	IEC 60384-14 4.13	X1: 4.0 KV, X2: 2.5 KV Y2: 5.0 KV Number of impulses: 24 maximum	There shall be no permanent breakdown or flashover.											

Storage & Handling

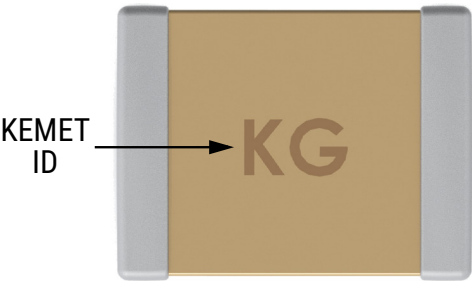
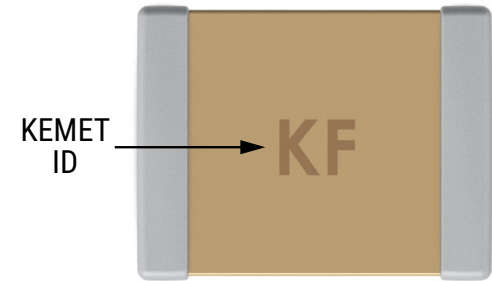
Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature—reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. In addition, temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 12 months of receipt.

Construction



Marking

Subclass Designation	Marking
X1/Y2	KF
X2	KG



Tape & Reel Packaging Information

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12, 16 and 24 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.

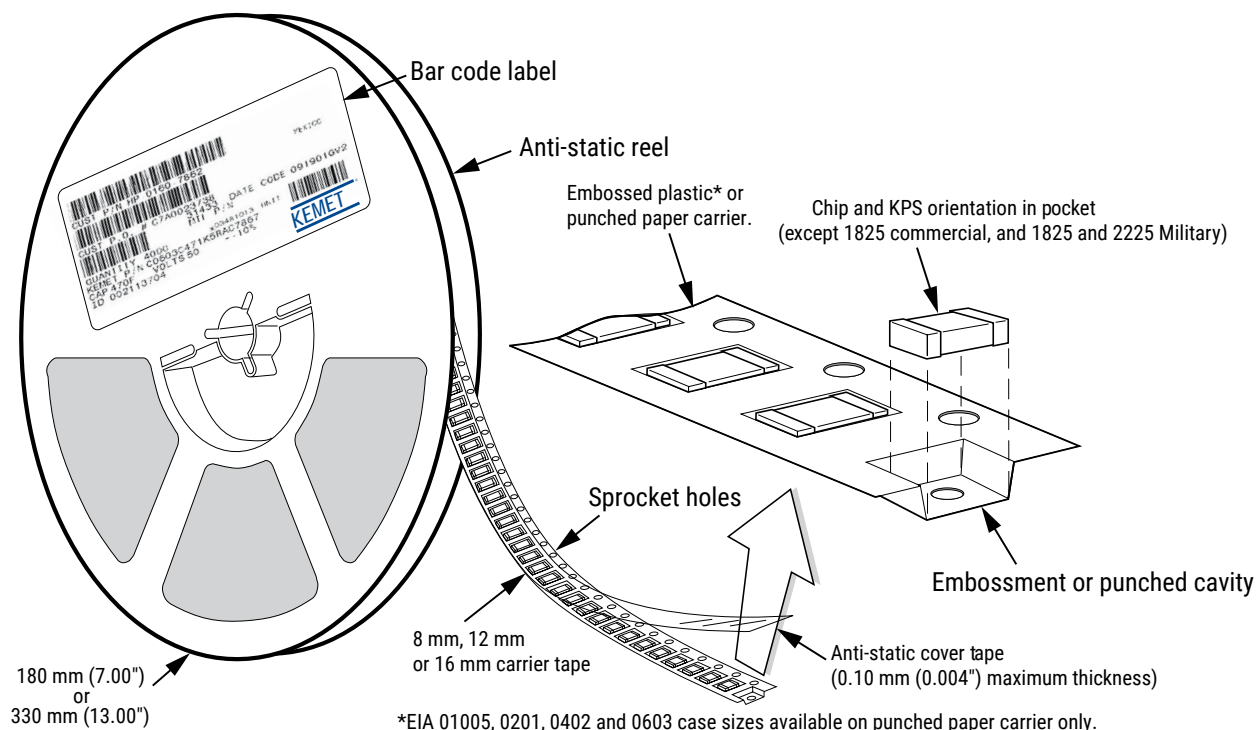


Table 5 – Carrier Tape Configuration, Embossed Plastic (mm)

EIA Case Size	Tape Size (W)*	Embossed Plastic
		7" Reel
		Pitch (P ₁)*
1808	12	4
≥ 1812	12	8

*Refer to Figure 1 for W and P₁ carrier tape reference locations.

*Refer to Tables 4 and 5 for tolerance specifications.

Figure 1 – Embossed (Plastic) Carrier Tape Dimensions

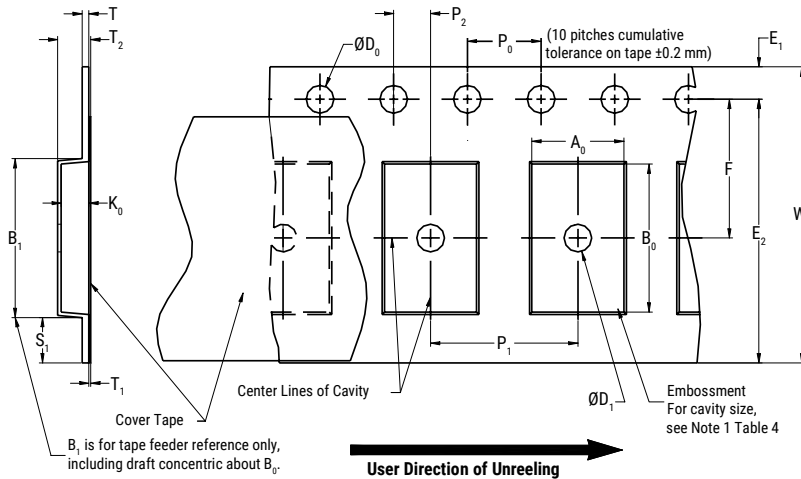


Table 6 – Embossed (Plastic) Carrier Tape Dimensions

Metric will govern

Constant Dimensions – Millimeters (Inches)									
Tape Size	D ₀	D ₁ Minimum Note 1	E ₁	P ₀	P ₂	R Reference Note 2	S ₁ Minimum Note 3	T Maximum	T1 Maximum
12 mm	1.5 +0.10/-0.0 (0.059 +0.004/-0.0)	1.5 (0.059)	1.75±0.10 (0.069±0.004)	4.0±0.10 (0.157±0.004)	2.0±0.05 (0.079±0.002)	30 (1.181)	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)
Variable Dimensions – Millimeters (Inches)									
Tape Size	Pitch	B ₁ Maximum Note 4	E ₂ Minimum	F	T ₂ Maximum	W Maximum	A ₀ , B ₀ , and K ₀		
12 mm	Single (4 mm) and Double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5±0.05 (0.217±0.002)	4.6 (0.181)	12.3 (0.484)	Note 5		

1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of embossment location and hole location shall be applied independent of each other.
2. The tape with or without components shall pass around R without damage (see Figure 6).
3. If $S_1 < 1.0$ mm, there may not be enough area for cover tape to be properly applied (see EIA Document 481 paragraph 4.3 (b)).
4. B_1 dimension is a reference dimension for tape feeder clearance only.
5. The cavity defined by A_0 , B_0 , and K_0 shall surround the component with sufficient clearance that:
 - (a) the component does not protrude above the top surface of the carrier tape.
 - (b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
 - (c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3).
 - (d) lateral movement of the component is restricted to 0.5 mm maximum for 8 mm and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4)
 - (e) For KPS Series product, A_0 and B_0 are measured on a plane 0.3 mm above the bottom of the pocket.
 - (f) see Addendum in EIA Document 481 for standards relating to more precise taping requirements.

Packaging Information Performance Notes

- 1. Cover Tape Break Force:** 1.0 kg minimum.
- 2. Cover Tape Peel Strength:** The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength
8 mm	0.1 to 1.0 Newton (10 to 100 gf)
12 and 16 mm	0.1 to 1.3 Newton (10 to 130 gf)
24 mm	0.1 to 1.6 Newton (10 to 160 gf)

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be 165° to 180° from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of 300±10 mm/minute.

- 3. Labeling:** Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards 556 and 624.*

Figure 2 – Maximum Component Rotation

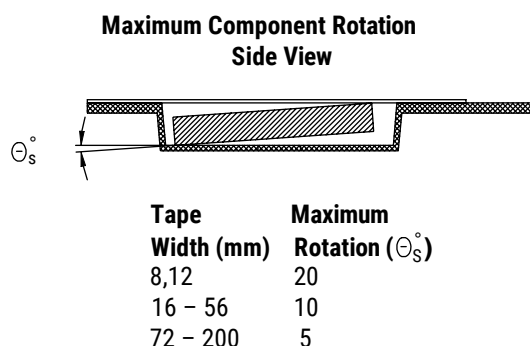
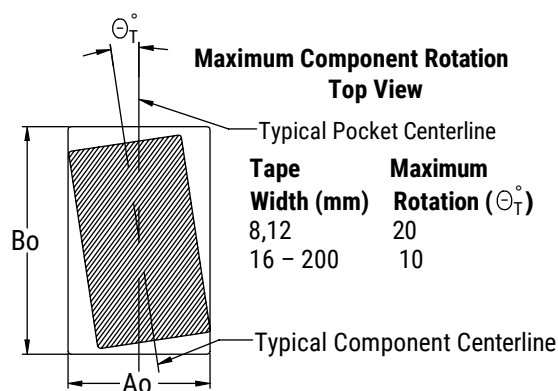


Figure 3 – Maximum Lateral Movement

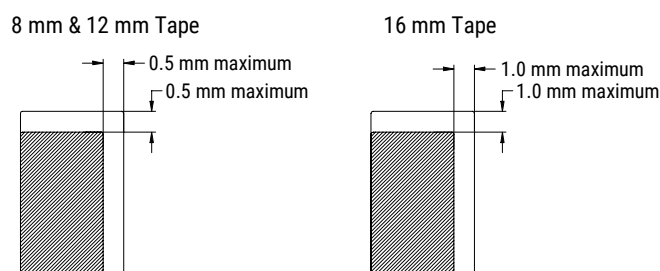


Figure 4 – Bending Radius

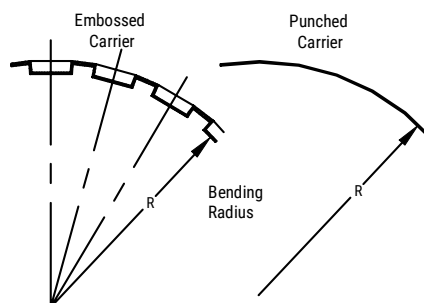


Figure 5 – Reel Dimensions

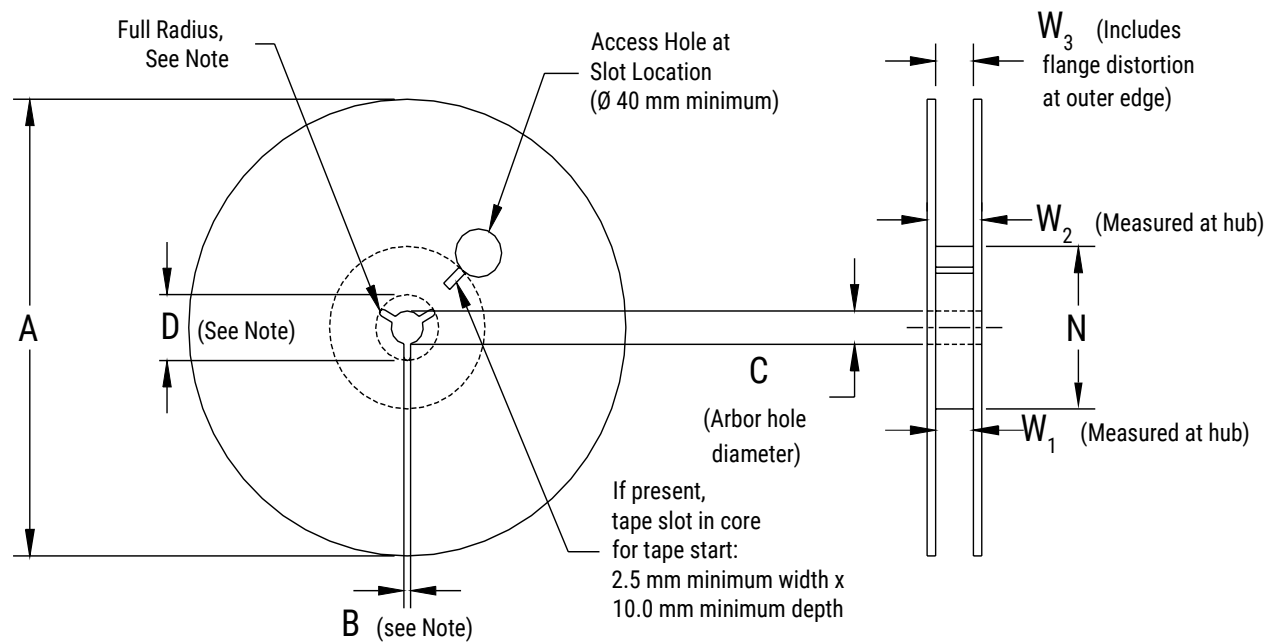


Table 7 – Reel Dimensions

Metric will govern

Constant Dimensions – Millimeters (Inches)				
Tape Size	A	B Minimum	C	D Minimum
12 mm	178±0.20 (7.008±0.008) or 330±0.20 (13.000±0.008)	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)
Variable Dimensions – Millimeters (Inches)				
Tape Size	N Minimum See Note 2, Tables 2-3	W ₁	W ₂ Maximum	W ₃
12 mm	50 (1.969)	12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	Shall accommodate tape width without interference

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